precursor in an organic solvent to form a varnish;

- (d) coating the varnish on a substrate of a circuit board;
- (e) heat curing the varnish, whereupon the reactive groups at the ends cross-link, to form the dielectric film on the substrate.
- 10. (NEW) The method as recited in claim 9, further comprising the step of:
 - (f) surface polishing the film.

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- 11. (NEW) The method as recited in claim 10, wherein steps (d), (e) and (f) are repeated to form a multilayer circuit board.
- 12. (NEW) The method as recited in claim 9, wherein step (e) includes heating at 200°C for thirty minutes, and heating at 350°C for 1-2 hours.
- 13. (NEW) The method as recited in claim 12, wherein prior to said heating step (e), preheating occurs at 100-120°C for about 10-20 minutes.
- 14. (NEW) The method as recited in claim 9, wherein either or both of the o-aminophenol compound precursor and aromatic dicarboxylic acid compound precursor is chosen to contain at least one benzene ring substituted b one or more fluorine atoms or trifluoromethyl groups or at least one moiety with one or more trifluoromethyl groups.
- 15. (NEW) The method as recited in claim 9, wherein the dielectric film is chosen to have a dielectric constant of less than 2.5.

II. REMARKS

A. Rejections in August 7, 2002 Office Action

1. Claims 1-8

Claims 1-8 are rejected as being made obvious by the combination of Murayama et al.